

<b>Notice of References Cited</b>	Application/Control No. 10/720,564	Applicant(s)/Patent Under Reexamination RESTLE, PHILLIP J.	
	Examiner Naum B. Levin	Art Unit 2825	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,978,231	11-1999	Tohya et al.	361/782
*	B	US-6,016,082	01-2000	Cruz et al.	331/117FE
*	C	US-6,057,724	05-2000	Wann, Hsing-Jen	327/292
*	D	US-2005/0057286	03-2005	Shepard et al.	327/141
*	E	US-2003/0161128	08-2003	Masuda, Hiroo	361/792
*	F	US-2004/0080664	04-2004	Riccardi et al.	348/372
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.